## Notice of References Cited Application/Control No. 10/789,441 Examiner Curtis Alia Applicant(s)/Patent Under Reexamination ASCHEUER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0150147 A1	10-2002	Liang, Ping	375/133
*	В	US-2003/0031231 A1	02-2003	You et al.	375/133
*	С	US-2003/0026269 A1	02-2003	Paryani, Harish P.	370/401
*	D	US-2003/0081603 A1	05-2003	Rune, Johan	370/390
*	Е	US-2003/0103487 A1	06-2003	Kim et al.	370/350
*	F	US-2004/0165576 A1	08-2004	Reunamaki, Jukka	370/350
*	G	US-2004/0176065 A1	09-2004	Liu, Bo	455/343.1
*	н	US-2004/0204031 A1	10-2004	Kardach et al.	455/552.1
*	1	US-2004/0202125 A1	10-2004	Sakamoto et al.	370/331
*	J	US-2005/0254525 A1	11-2005	Diamond et al.	370/503
*	K	US-7,035,235 B2	04-2006	Jose, Jaku	370/330
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number  Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	7					
	0				•	
	Р				,	,
	Q					·
	R			·		
	s			•		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.